

FORM PTO-1449		US DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		Any. Docket No. 84027SLP Customer No. 01333		Serial No. 10/098,642	
If AFTER the later date of the first Office Action or 3 months from filing, use only with Rule 97(E) Certificate or Fee				Applicant: Tiecheng A. Qiao, et al			
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				Filing Date 15 March 2002		Group 1634	
U.S. PATENT DOCUMENTS							
Examiner Initial*	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
W	6,023,540	02-08-2000	Walt et al.			03-14-1997	
FOREIGN PATENT DOCUMENTS							
Examiner Initial*	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO	
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)							
W	Jane Ferguson, Frank Steemers, David Walt, "High-Density Fiber-Optic DNA Random Microsphere Array", Anal. Chem. 2000, Vol. 72, pp.5618-5624						
EXAMINER W				DATE CONSIDERED 8/04			
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

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Dupl. c'd
8/84